



RADIO TEST REPORT

Test Report No. : 31CE0189-HO-03-B-R1

Applicant : **Panasonic Corporation of North America**
Type of Equipment : **Printer**
Model No. : **JT-H340PR-E1**
FCC ID : **ACJJT-H340PR1**
Test regulation : **FCC Part 15 Subpart C: 2010**
Test Result : **Complied**

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4. The test results in this report are traceable to the national or international standards.
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6. This report is a revised version of 31CE0189-HO-03-B. 31CE0189-HO-03-B is replaced with this report.

Date of test:

November 27 to December 2, 2010

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MF058b (12.01.11)

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SECTION 1: Customer information

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* Panasonic System Networks Co., Ltd. is on behalf of the applicant : Panasonic Corporation of North America.

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : Printer
Model No. : JT-H340PR-E1
Serial No. : Refer to Section 4, Clause 4.2
Rating : DC7.2V (Battery), DC9.5V (AC Adaptor)
Receipt Date of Sample : November 26, 2010
Country of Mass-production : Japan
Condition of EUT : Engineering prototype
(Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT : No Modification by the test lab

2.2 Product Description

Model No: JT-H340PR-E1, (referred to as the EUT in this report), is the Printer.
Printer that can print thermal recording paper by four inches in width of paper and can be carried.
Printed data are sent by Bluetooth, USB, and IrDA I/F from PC or Handheld PC etc.
It has Charge circuit of built-in battery.

General Specification

Clock frequency(ies) in the system	:	CPU:66.4MHz, USB Controller : 48MHz, Bluetooth Controller : 16MHz, Bluetooth Communication Clock : 26MHz
Power Supply	:	Battery: DC 7.2V 1300 / 1600mAh AC Adaptor: DC9.5V (AC120V/60Hz)

Radio Specification

Radio Type	:	Transceiver (Bluetooth Ver.2.1 + EDR Compliance (Class 2))
Frequency of Operation	:	2402-2480MHz
Bandwidth & Channel spacing	:	1MHz & 1MHz/CH
Modulation	:	FHSS
Power Supply (radio part input)	:	DC 3.1 to 3.3V
Antenna type	:	Chip Antenna
Antenna Gain	:	+2.1 dBi

Series model

JT-H340PR-XX (X: maybe any alphanumeric character, dash or blank)

Model Differences

Suffix "X" in model name JT-H340PR-XX is replaced with any alphanumeric character, dash or blank to denote the difference in case color, logo design, appearance of operation panel, label design, and USB input connector.

JT-H340PR-E1 has series model as Model No. JT-H340PR-E8.

The difference: JT-H340PR-E1 (Paper roll width is 114mm) and JT-H340PR-E8 (Paper roll width is 80mm).

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 15 Subpart C: 2010, final revised on December 6, 2010 and effective January 5, 2011

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.207 Conducted limits
Section 15.247 Operation within the bands 902-928MHz,
2400-2483.5MHz, and 5725-5850MHz

*The revision on December 6, 2010 does not affect the test specification applied to the EUT.

3.2 Procedures and results

Item	Test Procedure	Specification	Worst Margin	Results	Remarks
Conducted Emission	FCC: ANSI C63.4:2003 7. AC powerline conducted emission measurements IC: RSS-Gen 7.2.2	FCC: Section 15.207 IC: RSS-Gen 7.2.2	N/A *1)	N/A	N/A
Carrier Frequency Separation	FCC: FCC Public Notice DA 00-705 IC: -	FCC: Section15.247(a)(1) IC: RSS-210 A8.1 (b)	See data.	Complied	Conducted
20dB Bandwidth	FCC: FCC Public Notice DA 00-705 IC: -	FCC: Section15.247(a)(1) IC: RSS-210 A8.1 (a)		Complied	Conducted
Number of Hopping Frequency	FCC: FCC Public Notice DA 00-705 IC: -	FCC: Section15.247(a)(1)(iii) IC: RSS-210 A8.1 (d)		Complied	Conducted
Dwell time	FCC: FCC Public Notice DA 00-705 IC: -	FCC: Section15.247(a)(1)(iii) IC: RSS-210 A8.1 (d)		Complied	Conducted
Maximum Peak Output Power	FCC: FCC Public Notice DA 00-705 IC: RSS-Gen 4.8	FCC: Section15.247(b)(1) IC: RSS-210 A8.4 (2)		Complied	Conducted
Spurious Emission & Band Edge Compliance	FCC: FCC Public Notice DA 00-705 IC: RSS-Gen 4.9 RSS-Gen 4.10	FCC: Section15.247(d) IC: RSS-210 A8.5 RSS-Gen 7.2.1 and 7.2.3	[Tx] 3.5dB 2484.467MHz, AV, Hori [Rx] 21.0dB 1627.000MHz, AV, Vert.	Complied	Conducted/ Radiated

Note: UL Japan, Inc.'s EMI Work Procedures No.QPM05 and QPM15.

*1) The test is not applicable since the radio part does not operate during the usage of AC power port.

* In case any questions arise about test procedure, ANSI C63.4: 2003 is also referred.

FCC 15.31 (e)

This EUT provides stable voltage (DC3.1V to 3.3V) constantly to RF Part regardless of input voltage. Therefore, this EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

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3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99% Occupied Bandwidth	IC: RSS-Gen 4.6.1	IC: RSS-Gen 4.6.1	N/A	N/A	Conducted

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

EMI

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Test room (semi-anechoic chamber)	Radiated emission						
	(3m*)(+dB)				(1m*)(+dB)		(0.5m*)(+dB)
	9kHz -30MHz	30MHz -300MHz	300MHz -1GHz	1GHz -10GHz	10GHz -18GHz	18GHz -26.5GHz	26.5GHz -40GHz
No.1	3.5dB	5.1dB	5.2dB	4.8dB	5.1dB	4.4dB	4.3dB
No.2	4.0dB	5.1dB	5.2dB	4.8dB	5.0dB	4.3dB	4.2dB
No.3	4.2dB	4.7dB	5.2dB	4.8dB	5.0dB	4.5dB	4.2dB
No.4	4.0dB	5.0dB	5.1dB	4.8dB	5.0dB	5.1dB	4.2dB

*3m/1m/0.5m = Measurement distance

Power meter (+dB)	
Below 1GHz	Above 1GHz
1.0dB	1.0dB

Antenna terminal conducted emission and Power density (+dB)			Antenna terminal conducted emission (+dB)		Channel power (+dB)
Below 1GHz	1GHz-3GHz	3GHz-18GHz	18GHz-26.5GHz	26.5GHz-40GHz	
1.0dB	1.1dB	2.7dB	3.2dB	3.3dB	1.5dB

Radiated emission test(3m)

[Receiver Spurious Emission] The data listed in this test report has enough margin, more than the site margin.

[Transmitter Spurious Emission] The data listed in this report meets the limits unless the uncertainty is taken into consideration.

3.5 Test Location

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	FCC Registration Number	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	313583	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	655103	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	148738	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	134570	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	-	4.0 x 4.5 x 2.7m	4.75 x 5.4 m	-
No.6 measurement room	-	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	-	8.0 x 4.5 x 2.8m	2.0 x 2.0m	-
No.10 measurement room	-	-	2.6 x 2.8 x 2.5m	2.4 x 2.4m	-
No.11 measurement room	-	-	3.1 x 3.4 x 3.0m	2.4 x 3.4m	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test set up, Data of EMI, and Test instruments

Refer to APPENDIX.

SECTION 4: Operation of E.U.T. during testing

4.1 Operating Mode(s)

Bluetooth (BT): Transmitting (Tx), Payload: PRBS9
Receiving (Rx)
Inquiry

Details of Operating Mode(s)

Test Item	Mode	Tested frequency
Spurious Emission (Conducted/Radiated)	Tx (Hopping off) DH5, 3DH5	2402MHz 2441MHz 2480MHz
	Rx	2441MHz
Carrier Frequency Separation	Tx (Hopping on) DH5, 3DH5	2402MHz 2441MHz 2480MHz
	Inquiry	2441MHz
20dB Bandwidth	Tx (Hopping off) DH5, 3DH5	2402MHz 2441MHz 2480MHz
	Inquiry	2441MHz
Number of Hopping Frequency	Tx (Hopping on) DH5, 3DH5	-
	Inquiry	-
Dwell time	Tx (Hopping on), -DH1, DH3, DH5 -3DH1, 3DH3, 3DH5	-
	Inquiry	-
Maximum Peak Output Power	Tx (Hopping off) DH5, 3DH5	2402MHz 2441MHz 2480MHz
	Inquiry	2441MHz
Band Edge Compliance (Conducted)	Tx DH5, 3DH5 -Hopping on	-
	Tx DH5, 3DH5 -Hopping off	2402MHz 2480MHz
99% Occupied Bandwidth	Tx DH5, 3DH5, Inquiry -Hopping on	-
	Tx DH5, 3DH5 -Hopping off	2402MHz 2441MHz 2480MHz
*As a result of preliminary test, the formal test was performed with the above modes, which had the maximum payload length (except Dwell time test) *EUT has the power settings by the software as follows; Power settings: BDR: Ext.=255, Int.=53 EDR: Ext.=255, Int.=95 Software: CSR BlueSuite BlueTest Version 2.2.0.0 CSR BlueSuite BtCliCtrl Version 2.2.0.0 (Inquiry mode only)		

4.2 Configuration and peripherals

A: EUT

* Setup(s) were taken into consideration and test data was taken under worse case conditions.

Description of EUT

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Printer	JT-H340PR-E1	00004	Panasonic System Networks Co., Ltd.	EUT

SECTION 5: Radiated Spurious Emission

Test Procedure

EUT was placed on a urethane platform of nominal size, 0.5m by 1.0m, raised 0.8m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

The height of the measuring antenna varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer.

The measurements were made with the following detector function of the test receiver and the Spectrum analyzer (in linear mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

Test Antennas are used as below;

Frequency	Below 30MHz	30MHz to 300MHz	300MHz to 1GHz	Above 1GHz
Antenna Type	Loop	Biconical	Logperiodic	Horn

In any 100kHz bandwidth outside the restricted band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator confirmed 20dB below that in the 100kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement.

20dBc was applied to the frequency over the limit of FCC 15.209 / Table 2 of RSS-210 2.7 (IC) and outside the restricted band of FCC15.205 / Table 1 of RSS-210 2.7 (IC).

Frequency	Below 1GHz	Above 1GHz		20dBc
Instrument used	Test Receiver	Spectrum Analyzer		Spectrum Analyzer
Detector	QP	PK	AV	PK
IF Bandwidth	BW 120kHz(T/R)	RBW: 1MHz VBW: 3MHz	RBW: 1MHz VBW: 10Hz or RBW: 1MHz VBW: 270Hz *1)	RBW: 100kHz VBW: 300kHz (S/A)
Test Distance	3m	3m (below 10GHz), 1m*2) (above 10GHz)		3m

*1) Used for the band edge of the carrier and the harmonics that can be measured. The VBW is based on the inverse of the duty cycle (see Appendix).

*2) Distance Factor: $20 \times \log(3.0\text{m}/1.0\text{m}) = 9.5\text{dB}$

- The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Measurement range : 30M-26.5GHz
Test data : APPENDIX
Test result : Pass

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SECTION 6: Antenna Terminal Conducted Tests

Test Procedure

The tests were made with below setting connected to the antenna port.

Test	Span	RBW	VBW	Sweep time	Detector	Trace	Instrument used
20dB Bandwidth	3MHz	30kHz	30kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99% Occupied Bandwidth	Enough width to display 20dB Bandwidth	1 to 3% of Span	Three times of RBW	Auto	Peak *1)	Max Hold *1)	Spectrum Analyzer
Maximum Peak Output Power	-	-	-	Auto	Peak	-	Power Meter (Sensor: 50MHz BW)
Carrier Frequency Separation	3MHz	100kHz	300kHz	Auto	Peak	Max Hold	Spectrum Analyzer
Number of Hopping Frequency	30MHz	300kHz	1MHz	Auto	Peak	Max Hold	Spectrum Analyzer
Dwell Time	Zero Span	1MHz	3MHz	As necessary capture the entire dwell time per hopping channel	Peak	Max Hold	Spectrum Analyzer
Conducted Spurious Emission	Less or equal to 5GHz (Range: 30MHz-25GHz)	100kHz	300kHz	Auto	Peak	Max Hold	Spectrum Analyzer
Conducted Spurious Emission Band Edge compliance	20MHz	300kHz	1MHz	Auto	Peak	Max Hold	Spectrum Analyzer

*1) The measurement was performed with Peak Detector, Max Hold since the duty cycle was not 100%.

The test results and limit are rounded off to two decimals place, so some differences might be observed.

Test data : APPENDIX

Test result : Pass